

Search Notes**Application/Control No.**

10616525

Applicant(s)/Patent Under Reexamination

FUNK ET AL.

Examiner

Rutten, J. Derek

Art Unit

2192

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
717/127-130; 714/34,35 (Updated text search - see search history printout)	7/6/07	/jdr/
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT - see search history printout)	7/6/07	/jdr/

INTERFERENCE SEARCH

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